quantitative analysis of the critical current due to vortex pinning by surface corrugation.

A.Pautrat,¹, J.Scola,¹ C.Goupil,¹ Ch.Simon,¹ C.Villard,² B.Domenges,³ Y.Simon,⁴ C.Guilpin,⁵ and L.Mechin⁶

 $^{1}\text{CRISMAT}/\text{ENSICAEN}$, UMR 6508 du CNRS,14050 Caen, France.

²CRTBT/CRETA, UPR 5001 du CNRS, 38042 Grenoble, France.

- ³LAM IP, Phillips/ENSICAEN, 14050 Caen, France.
- ⁴LPMC de l'Ecole Norm ale Superieure, UMR 8551 du CNRS,

associee aux universites Paris 6 et 7, 75231 Paris Cedex5, France.

⁵GPS, UMR 7588 du CNRS, associee aux universites Paris 6 et 7, 75251 Paris Cedex5, France.

⁶GREYC/ENSICAEN, UMR 6072 du CNRS,14050 Caen, France.

The transport critical current of a N iobium (N b) thick Im has been measured for a large range of magnetic eld. Its value and variation are quantitatively described in the framework of the pinning of vortices due to boundary conditions at the rough surface, with a contact angle well explained by the spectral analysis of the surface roughness. Increasing the surface roughness using a Focused Ion B eam results also in an increase of the super cial critical current.

PACS num bers: 74.60 E c, 74.60 G e, 61.12 E x, 74.70 A d.

IN T R O D U C T IO N

The understanding of the nature of the critical current in superconductors has triggered a lot of work for m any years [1, 2]. Practically speaking, quantitative predictions of the critical current values is a key point for m ost of the applications. M ore fundam entally, the question of the interaction of the vortex lattice with pinning centers is also a prototype system for understanding the behaviour of an elastic m edium submitted to a disorder potential β]. It is wellknown that a perfect vortex lattice (V L) submitted to a bulk transport current is subject to a

ow, that leads to a nite electro chemical eld and gives rise to dissipation [4]. The ability of the VL not to move when it is submitted to a transport current is generally explained by the pinning interactions between pinning centers and VL. Unfortunately, the exact nature of the pertinent pinning centers, and the way they are acting, is not straightforw ard. In soft sam ples where superconducting param eters vary slow ly in the sam ple, cristallographic bulk inhom ogeneities are usually supposed to play the role of pinning centers [2]. One can notice that this collective bulk pinning description leads to quite complex critical current expressions and to a corresponding lack of quantitative interpretation and prediction. On the other hand, experimental observation of the strong in uence of surface quality on VL pinning has been evidenced in pioneering experiments [5]. This surface in uence can be described in the fram ework of surface roughness interacting with VL, as proposed by M athieu-Sim on (MS) in a continuum approach. For any real sample, which presents a surface roughness at the VL scale, the respect of the boundary conditions [6] of term inating vortices at the surface in poses local bending. This de nes a contact angle (=0 for a at surface) and leads to a near-surface supercurrent. At the sample scale, this o ers a lot of m etastable equilibrium states. The ability of the system

to sustain a macroscopic supercurrent is then directly linked to the surface roughness via an average contact angle $_{\rm c}$. The macroscopic critical current (per unit of width) is simply given by

$$i_{c}(A = m) = ":sin(c)$$
(1)

where " is the vortex potential, i.e. the therm odynam icalpotential describing the equilibrium state. "P inning" is then nothing else than the consequence of vortex boundary conditions applied to a real surface [8]. This should a priori act in every sample. The remaining question is: what is the contribution of this surface critical current with respect to the overall critical current? The vortex potential can be measured from the reversible magnetic moment M = -v V of a superconducting volum e V, or calculated using, for example, A brikosov's solution close to B c2 . U sing an iteration procedure proposed by E.H. Brandt [10], " can be also obtained over the whole mixed state via num erical solutions of the G inzburg-Landau equations. Now if one assumes a physical value of $_{c} = 0-20 \deg$, a good order of m agnitude of ic is deduced [9]. A careful inspection of the surface state should in principle enable to extract a m ore precise value of this critical angle. If the usual measurem ent of surface roughness is the rm s (root-m ean-square) height h of the surface bum ps, the pertinent param eter is here more the distribution $(x) = \arctan(\frac{dh}{dx})$ of local slopes over the width of the surface. The rm s value of this angle is given by the integration of the spectral density $\frac{1}{k_{m}} = \frac{1}{k_{m}} \frac{1}{k_{m$ k_{max} S dk over the appropriate k boundaries [11]. S is the Fourier transform of the autocorrelation of (x) (W iener-K hintchine theorem), which represents the spatial distribution of . The aim of the present study is to measure the critical current of a Niobium thick Im, with various surface corrugation, and to com pare the experim ental values to those obtained with the

simple expression (1). " will be calculated using B randt's approach, and $_{\rm c}$ compared to $\frac{p}{2}$.

EXPER IM ENTAL

The sample used is a lm of Niobium (thickness= 3000 A) deposited at 780C on a sapphire substrate by the ion beam technique. The lm has a resistivity of about 0.5

cm at the critical temperature $T_{\rm c}=9.15$ K and exhibits a low surface ms roughness (R $_{\rm a}$ $^<$ 5 nm), measured by A tom ic Force M icroscopy (N anoscope III, D igital Instruments). M icrobridges of W = 10 m L=30 m have been patterned using a scanning electronic m icroscope, this irradiation step being followed by a reactive ion etching process. The critical currents have been measured by m ean of the standard four-probe technique, at the follow ing temperatures of 4.2, 5.2, 6.2 K in the whole range of eld covering the m ixed state. The critical current values $I_{\rm c}$ were determ ined with a voltage criteria of 10 nV .

RESULTS AND DISCUSSION

Let us not discuss the general behavior of the L(!) data (g.1) for the virgin m icrobridge at di erent tem – peratures (! is the vortex eld inside the sample and corresponds to the vortex density $n = \frac{!}{0}$). Note that the dem agnetization factor due to the geometry of the thin

In renorm alizes the apparent rst critical eld B_1 up to about 0.015 B_{clbulk}. It im plies that the mixed state is created for the lowest eld value applied (30G auss). Except for this peculiarity, I_c(!) exhibits the same eld variation as the reversible magnetization curve of a type II superconductor, in agreement with the expected variation of super cial currents i (equation 1 with c cte). We also notice that the curves taken at 42, 52 or 62 K are self similar, that is they can be superim posed by a mere rescaling. As rst noted in pioneering work on vortex pinning [12], the change of critical current with tem perature can be totally attributed to the change in prim ary superconducting properties. It is evidenced in

gure 2 where the low eld value of J is shown to be sim – ply proportional to B_{c2} for the three tem peratures and both for the virgin and for the dam aged sam ple. This shows that the variation of I_c with tem perature is sim – ply due to the variation of the vortex potential "(T) (i.e. the variation of super uid density), without the need of involving other therm all elects such as vortex therm aldiffusion. Now if we want to verify quantitatively equation (1), we rst need to know the vortex potential". It is usually approxim ated using the A brikosov calculations from B_{c2} down to 0.4-0.5 B_{c2}, and by the London expression at very low elds B $^>$ B_{c1}. For low kappa superconductors such as pure N iobium (1) for a sam ple with properties

very close to ours [13][14]), only the A brikosov expression is quantitatively correct and it is necessary to use num erical calculations to solve the G inzburg Landau equations over the whole eld range, following for example Brandt's iterative m ethod [15]. The result is presented in gure 3, for = 1. We can now deduce the critical angle needed to account for the measured critical current. For a pure surface pinning and following equation (1), the expected value of $_{\rm c}$ is given by $_{\rm c}$ arcsin (i_c/"). U sing the numerical values of ", we nd $_{\rm c}$ 0.4-1 deg (see qure 4), in agreem ent with the m ere expectation of a physicalangle. The order of magnitude is promising, but the complexity of the (multiscale) surface disorder needs a careful surface analysis. W e have therefore m easured the m icrobridge roughness using AFM in tapping mode (see g.5).

Following the simple analysis described in the introduction, we obtain the spectral density S with the use of the Fourier transform of the autocorrelation of (x) (W iener-K hintchine theorem). The main value of the statistically representative angle is given by the integration of the spectral density [11]: $\overline{2} = \frac{R_{k_{m}ax}}{0}$ S dk. The boundary of the integral have been chosen as the natural scale for the vortex lattice, considering that a vortex does not see a roughness less than its core size ($k_{m}ax = \frac{2}{-}$). Note that the choice of this cuto frequency does not signi cantly change the results. This calculation gives

0.60 0.18 deq. The agreem ent with the value deduced from the critical current m easurem ents (a m ean value of 0.70 0.15 deg) is quite promising. More precisely, this is, within error bars, what we obtained for the magnetic eld values higher than about 1000 G auss. It is worth noting that the main value that we calculate is statistically representative but gives also a value that is supposed to be independent of the frequency. We are fully aware that a more rigorous analysis should take into accountakind of matching e ect between the VL periodicity and the scale of surface disorder. It is even possible to expect a peculiar variation of i_c (!) in the case of a very rough surface at a restricted spatial scale. In this respect, one can see that the highest angles observed for low elds B < 0.1 T (a₀ > 0.5 m) are quite consistent with the highest angles observed in the surface pro le for a periodicity of about 1 m.

We decided also to compare this virgin microbridge with one whose surface structure wasm odi ed. The idea was to use a Focused Ion Beam to etch its surface following a controlled geometry. The expected shape was that of "corrugated iron" with 12 m by 0.1 m trenches regularly spaced by 1 m. Also, the etched depth should be high compared to the initial roughness of the surface, that is 30nm here. Several attempts have been performed using di erent G a ion doses, which should be as low as possible in order to minimize the e ect of G a irradiation, leading to the best control of the etched surface. Thus, the nalprocedure was eight identical patterns (12 m x 0.10 m x 0.03 m), etched parallel using an ion current of 4 pA corresponding to a total ion dose about 150 pC / m². The sample was tilted by 45 degrees and the magni cation used was 25kX .Figure 6 is a SEM image of the resulting etched m icrobridge; the trenches are evenly spaced and they yield geom etric param eters close to those expected (width about 0.15 m). Such low energy irradiation leads also to an implantation of Ga⁺ ions, but simulations using M onte-C arlo calculations [16] indicate that it a ects only a range of no more than 100A. Furtherm ore, we observe neither any change in the critical tem perature ($T_c = 9:15K$), nor in the norm al state re-0:50 cm) and critical elds within exsistivity (_n perim ental accuracy. In order to evaluate m ore precisely the in uence of the Ga irradiation, another m icrobridge was etched using a single rectangular pattern (12m x 8m x 0.03m), that is covering the whole width of the microbridge. The sample was tilted of 45 and the total ion dose close to 190pC / m². C ritical current and resistivity m easurem ents were perform ed on this m icrobridge and were compared to those on the virgin microbridge. We observed the sam e properties and specially that the critical current is very sim ilar (within few percents) in the two cases. This con med that the Ga irradiation had no in uence on the bulk physical properties of the lm. The FIB treatment, contrary to highest energy irradiation, has not modi ed the bulk crystalline lattice of the material and that the important modi cation is in the surface structure. We can therefore use the term "surface" dam ages. The main obvious result is the increase of the critical current, as shown in g. 7. Following the sam e procedure that we perform ed for the virgin m icro-2.2 0.3 deg in good enough bridge, one obtains agreem ent with the 1.5 0.2 deg deduced from the critical current values. W e note that the kind of treatm ent we perform ed leads to an increase of the roughness for a periodicity of about 0.1-1 m. In the inset of gure 7, one can evidence that the critical angle is alm ost unchanged for the highest magnetic eld values ! > 3000 G.For those values, the intervortex distance is less than 0.1 m and we nd using the AFM that the treated m icrobridge exhibits the same kind of roughness as the virgin m icrobridge for this periodicity. Again, the spatial dependence of the surface roughness is certainly linked with the exact $_{c}(!)$ variation, with ! xing the spatial scale of the pertinent surface disorder. M ore work is needed to fully describe this problem .

F inally, we conclude from this analysis that the critical current of our sample is given by equation (1) with a good agreem ent, for the virgin and for the surface dam aged m icrobridges. We conclude that taking into account the surface defects as main sources of pinning enables to explain the experimental critical current values. Expressed in the form of a surface critical current and due to the

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small surface corrugation of the NbFilm (a roughness of few nm m s), the critical current appears to have standard and even relatively sm all values for this low kappa 10-30 A/cm at low elds). If one superconductor (i_c expresses the critical current in the form of a density as it is usually made, this leads to a high value (J_c) 0.5 1:5 10^{6} A = cm²). We emphasize that this notion of density is by de nition not justi ed in the case of a current owing under the surface and not uniform ly in the bulk. As an example, Niobium crystals with a thickness of 7.6 10³ cm exhibit a critical current density of roughly 3.10^3 A/cm² at 0.1 T and 4.2 K [17]. This gives i_c=13.1 A/cm compared to 12.5 A/cm (our thin lm) under the sam e (!,T) conditions. So, The surface critical current is alm ost the same. It follows that the di erence of thickness makes this apparent (but not physically signi cant in term s of pinning "force") di erence in the critical current density values. Note that the same remark apply to other types of clean superconductors [18].

Now, if one increases a lot the number of bulk defects to obtain a spacing say less than the intervortex distance, we can obtain a so-called hard superconductor. In this case, a bulk subcritical current can ow by a percolating-like behavior. A nyway, in this case, the critical current density was shown, in a lot of cases, to be proportional both to the di erence in equilibrium magnetization across the internal boundaries and to the area of internal interface per unit volum e [19, 20, 21]. It is worth noting that this is the same kind of pinning by surface interactions, but in this case with internal interfaces.

In sum mary, we have observed that the value of the critical current of a thick Im of a standard type II superconductor is quantitatively explained with the vortex pinning by surface roughness. We have also observed the increase of this critical current caused by an increase of the surface corrugation. Furtherm ore, it gives a simple explanation for the high critical current density observed in this kind of clean thin Im s, compared to the moderated one observed in (thick) bulk crystals. We hope that it gives also evidence that the interaction between the surface corrugation and the vortex elasticity is a key point for the understanding of vortex lattice pinning and dynam ics.

A cknow ledgem ents: J. Scola acknow ledges support from "la region B asse N orm andie".

corresponding author: alain pautrate ism ra.fr

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FIG.1: The critical current of the virgin niobium m icrobridge as function of the vortex eld for three di erent tem peratures.

FIG.2: The critical current at 30 G auss as function of the second critical eld for the three tem peratures and the virgin and surface dam aged m icrobridges.

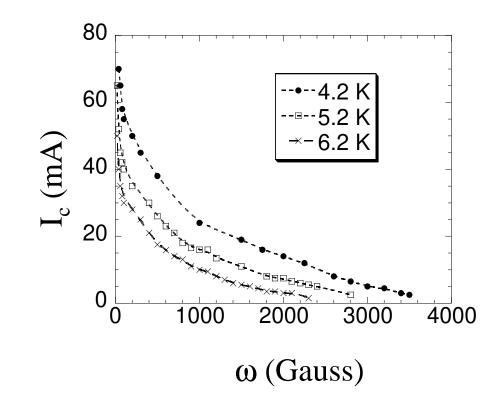
FIG.3: The variation of the vortex potential (or equilibrium m agnetization) as function of the magnetic eld for = 1 calculated with G inzburg-Landau equations and following the m ethod explained in [10]. The two are respectively norm alized over H $_{\rm C\,2}$ and B $_{\rm C\,2}$. The dashed line is the Abrikosov line.

FIG.4: The variation of the critical angle $_{\rm c}$ deduced from the arcsin $(\frac{k_{\rm c}}{n})$. The straight line corresponds to the main value extracted from the surface analysis.

FIG. 5: AFM picture of the surface roughness for the virgin m icrobridge. In the inset is shown the corresponding variation of local slopes over the width of the sample.

FIG. 6: a/SEM image of the treated microbridge showing the eight trenches (arrowed) in the niobium $lm \cdot b/D$ etail of one trench showing its geometric characteristics.

FIG.7: comparison of the critical currents for the virgin microbridge and for the one degraded with the FIB. In the inset is shown the critical angle variation deduced from equation (1).



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